



## 600V Super-Junction Power MOSFET

### DESCRIPTION

#### 600V super-junction Power MOSFET

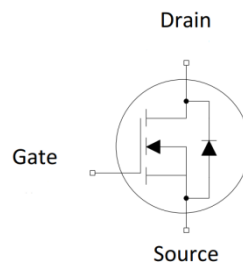
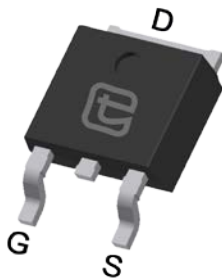
Super-junction power MOSFET is a revolutionary technology for high voltage power MOSFETs, designed according to the SJ principle. The SJ MOSFET is a price-performance optimized product enabling to target cost sensitive applications in Consumer and Lighting markets, designed by Wuxi Unigroup Microelectronics Company.

### FEATURES

- Very low FOM  $R_{DS(on)} \times Q_g$
- 100% avalanche tested
- RoHS compliant

### APPLICATIONS

- Switch Mode Power Supply (SMPS)
- Uninterruptible Power Supply (UPS)
- Power Factor Correction (PFC)



### Device Marking and Package Information

Device	Package	Marking
TPD60R330M	TO-252	60R330M

### Key Performance Parameters

Parameter	Value	Unit
$V_{DS} @ T_{j,max}$	600	V
$R_{DS(on),max}$	0.33	$\Omega$
$I_D$	11	A
$Q_{g,typ}$	19	nC
$I_{DM}$	33	A



<b>Absolute Maximum Ratings</b> $T_C = 25^\circ\text{C}$ , unless otherwise noted				
Parameter	Symbol	Value	Unit	
Drain-Source Voltage ( $V_{GS} = 0\text{V}$ )	$V_{DSS}$	600	V	
Continuous Drain Current	$I_D$	$T_C = 25^\circ\text{C}$	11	A
		$T_C = 100^\circ\text{C}$	6.6	
Pulsed Drain Current (note1)	$I_{DM}$	33	A	
Gate-Source Voltage	$V_{GSS}$	$\pm 30$	V	
Single Pulse Avalanche Energy (note2)	$E_{AS}$	210	mJ	
Repetitive Avalanche Energy (note2)	$E_{AR}$	0.32	mJ	
Avalanche Current	$I_{AR}$	1.8	A	
MOSFET dv/dt ruggedness, $V_{DS} = 0 \dots 480\text{V}$	dv/dt	50	V/ns	
Power Dissipation	$P_D$	83	W	
Continuous Body Diode Current	$I_S$	9.4	A	
Pulsed Diode Forward Current (note1)	$I_{SM}$	33		
Reverse diode dv/dt (note3)	dv/dt	15	V/ns	
Maximum diode commutation speed (note3)	$di/dt$	500	A/us	
Operating Junction and Storage Temperature Range	$T_J, T_{stg}$	-55~+150	$^\circ\text{C}$	

<b>Thermal Resistance</b>			
Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case	$R_{thJC}$	1.5	$^\circ\text{C/W}$
Thermal Resistance, Junction-to-Ambient	$R_{thJA}$	62	



Specifications $T_J = 25^{\circ}\text{C}$ , unless otherwise noted						
Parameter	Symbol	Test Conditions	Value			Unit
			Min.	Typ.	Max.	
<b>Static</b>						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = 250\mu\text{A}$	600	--	--	V
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 600V, V_{GS} = 0V, T_J = 25^{\circ}\text{C}$	--	--	1	$\mu\text{A}$
		$V_{DS} = 600V, V_{GS} = 0V, T_J = 150^{\circ}\text{C}$	--	--	50	
Gate-Source Leakage	$I_{GSS}$	$V_{GS} = \pm 30V$	--	--	$\pm 100$	nA
Gate-Source Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	2.5	--	4.5	V
Drain-Source On-Resistance	$R_{DS(on)}$	$V_{GS} = 10V, I_D = 5.5A$	--	0.29	0.33	$\Omega$
Gate resistance	$R_G$	$f = 1.0\text{MHz}$ open drain	--	18	--	$\Omega$
<b>Dynamic</b>						
Input Capacitance	$C_{iss}$	$V_{GS} = 0V,$ $V_{DS} = 100V,$ $f = 1.0\text{MHz}$	--	857	--	$\mu\text{F}$
Output Capacitance	$C_{oss}$		--	31	--	
Reverse Transfer Capacitance	$C_{rss}$		--	1.5	--	
Total Gate Charge	$Q_g$	$V_{DD} = 480V, I_D = 11A,$ $V_{GS} = 10V$	--	19.0	--	nC
Gate-Source Charge	$Q_{gs}$		--	4.8	--	
Gate-Drain Charge	$Q_{gd}$		--	7.2	--	
Turn-on Delay Time	$t_{d(on)}$	$V_{DD} = 400V, I_D = 11A,$ $R_G = 25\Omega$	--	28	--	ns
Turn-on Rise Time	$t_r$		--	61	--	
Turn-off Delay Time	$t_{d(off)}$		--	89	--	
Turn-off Fall Time	$t_f$		--	41	--	
<b>Drain-Source Body Diode Characteristics</b>						
Body Diode Voltage	$V_{SD}$	$T_J = 25^{\circ}\text{C}, I_{SD} = 5.5A, V_{GS} = 0V$	--	0.9	1.2	V
Reverse Recovery Time	$t_{rr}$	$V_R = 400V, I_F = I_S,$ $di_F/dt = 100A/\mu\text{s}$	--	377	--	ns
Reverse Recovery Charge	$Q_{rr}$		--	3.4	--	$\mu\text{C}$
Peak Reverse Recovery Current	$I_{rrm}$		--	17.8	--	A

**Notes**

1. Repetitive Rating: Pulse width limited by maximum junction temperature
2.  $I_{AS} = 1.8A, V_{DD} = 50V, R_G = 25\Omega$ , Starting  $T_J = 25^{\circ}\text{C}$
3. Identical low side and high side switch with identical  $R_G$



Typical Characteristics  $T_J = 25^\circ\text{C}$ , unless otherwise noted

Figure 1. Output Characteristics

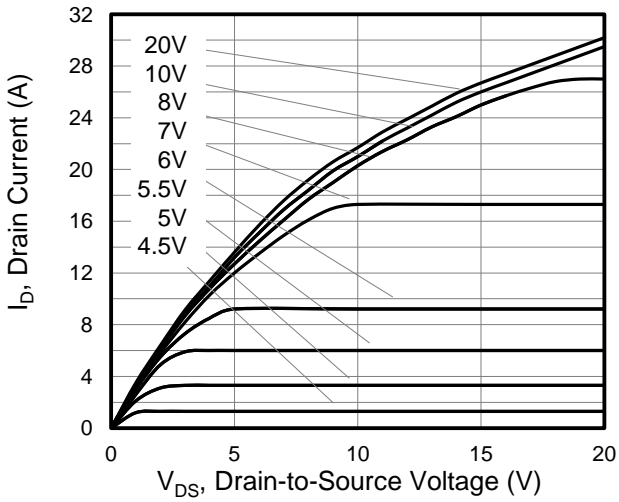


Figure 2. Transfer Characteristics

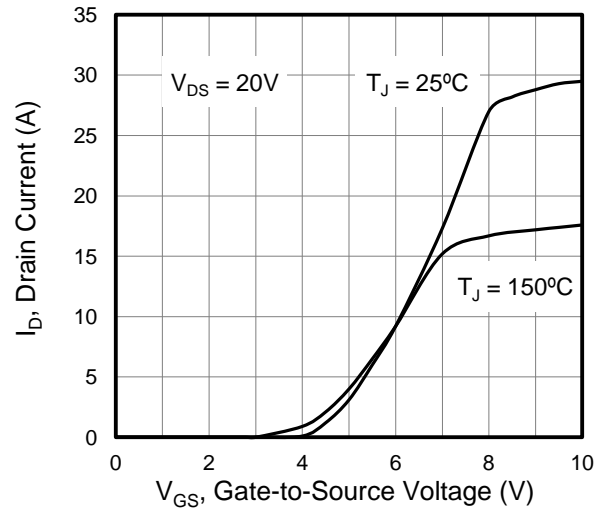


Figure 3. On-Resistance vs. Drain Current

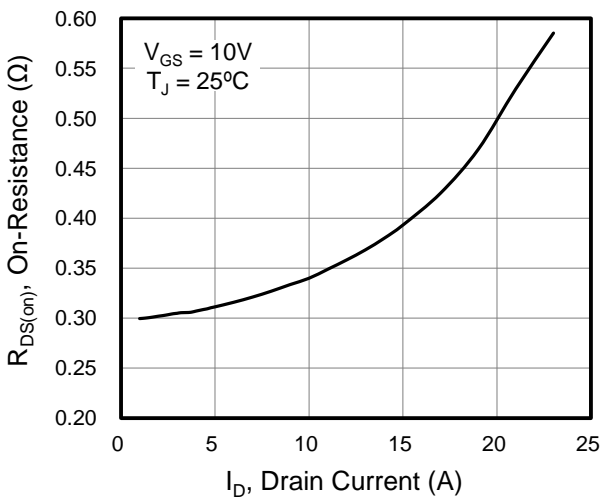


Figure 4. Capacitance

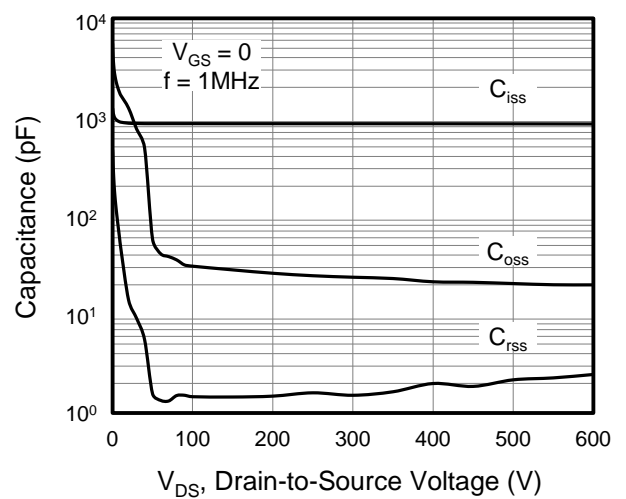


Figure 5. Gate Charge

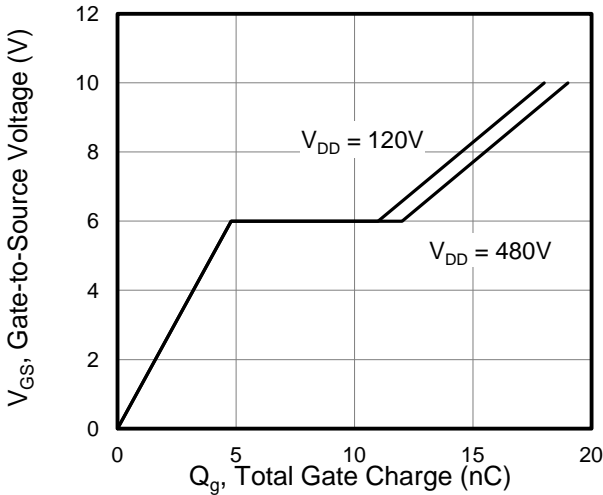
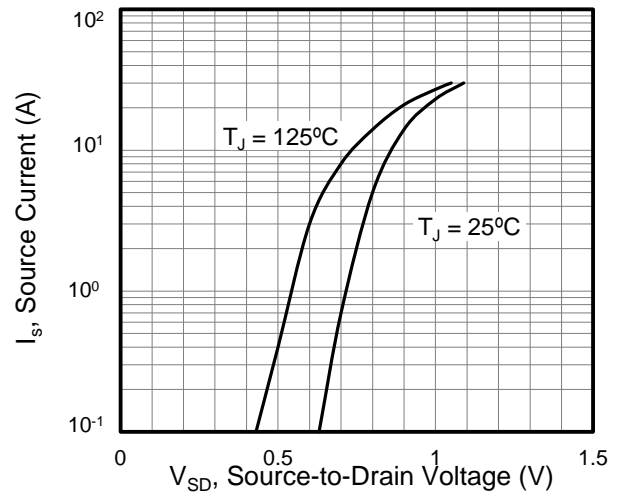


Figure 6. Body Diode Forward Voltage





Typical Characteristics  $T_J = 25^\circ\text{C}$ , unless otherwise noted

Figure 7. On-Resistance vs. Junction Temperature

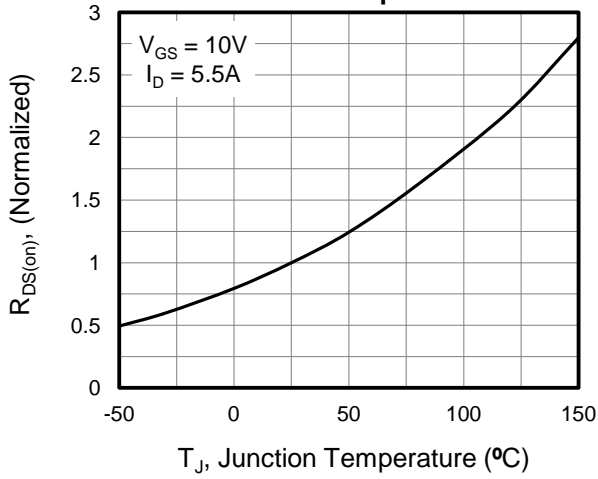


Figure 8. Breakdown voltage vs. Junction Temperature

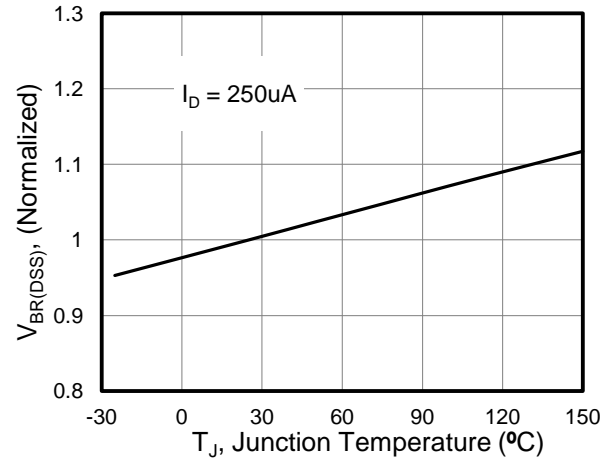


Figure 9. Transient Thermal Impedance TO-252

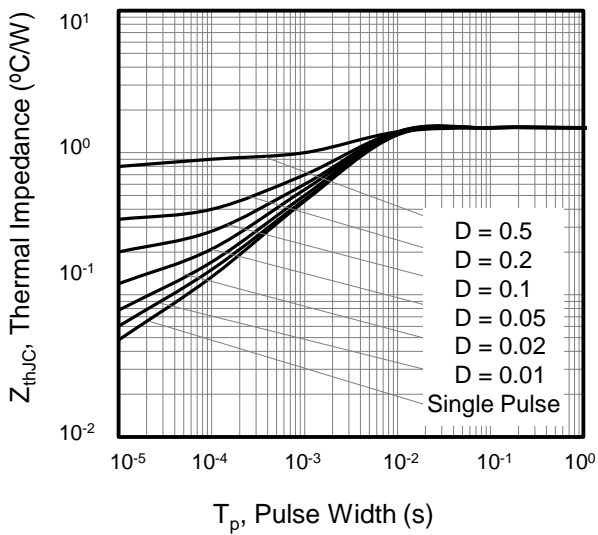


Figure 10. Safe operation area for TO-252

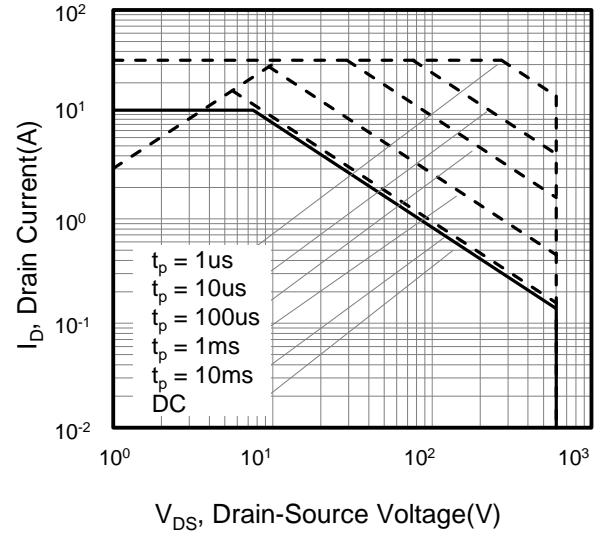




Figure A: Gate Charge Test Circuit and Waveform

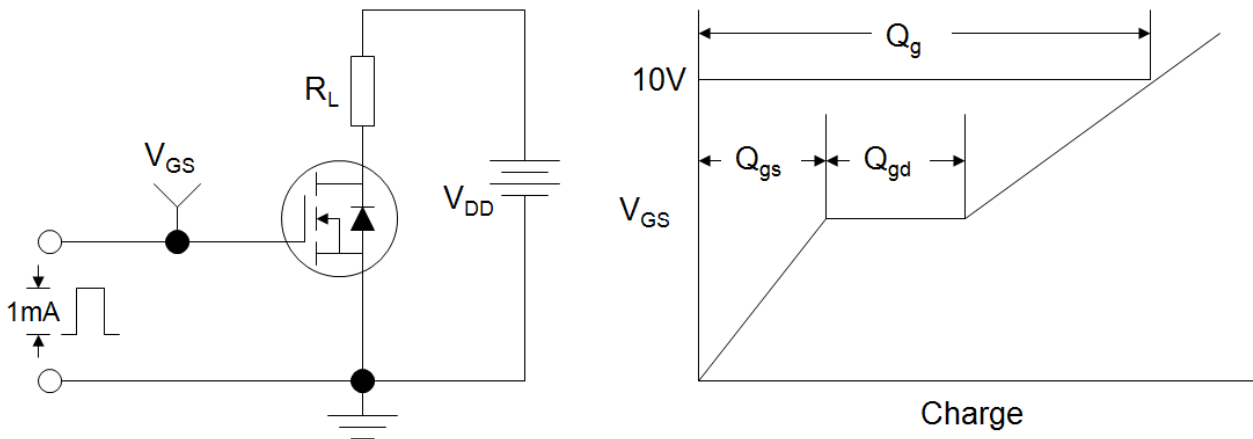


Figure B: Resistive Switching Test Circuit and Waveform

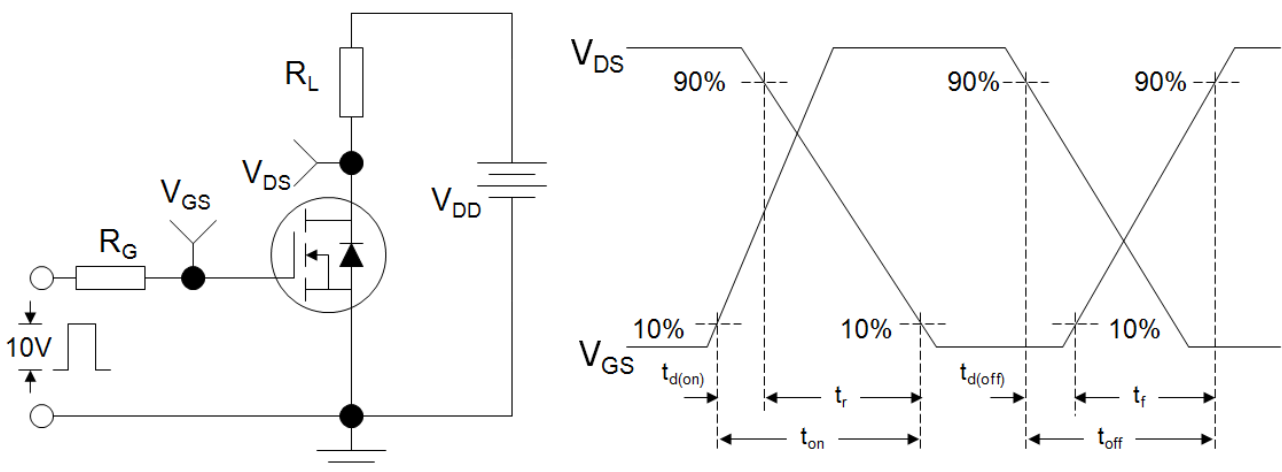
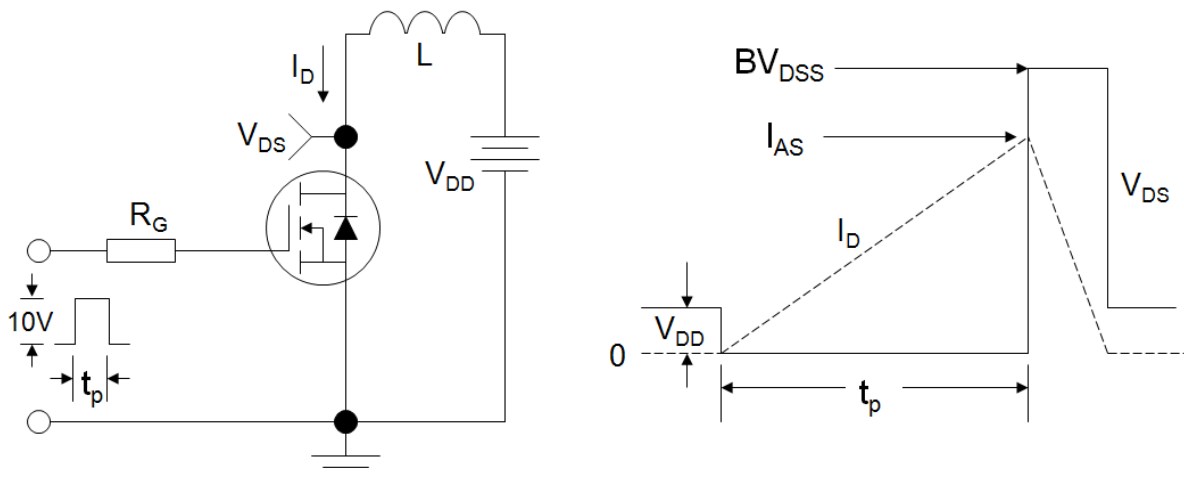
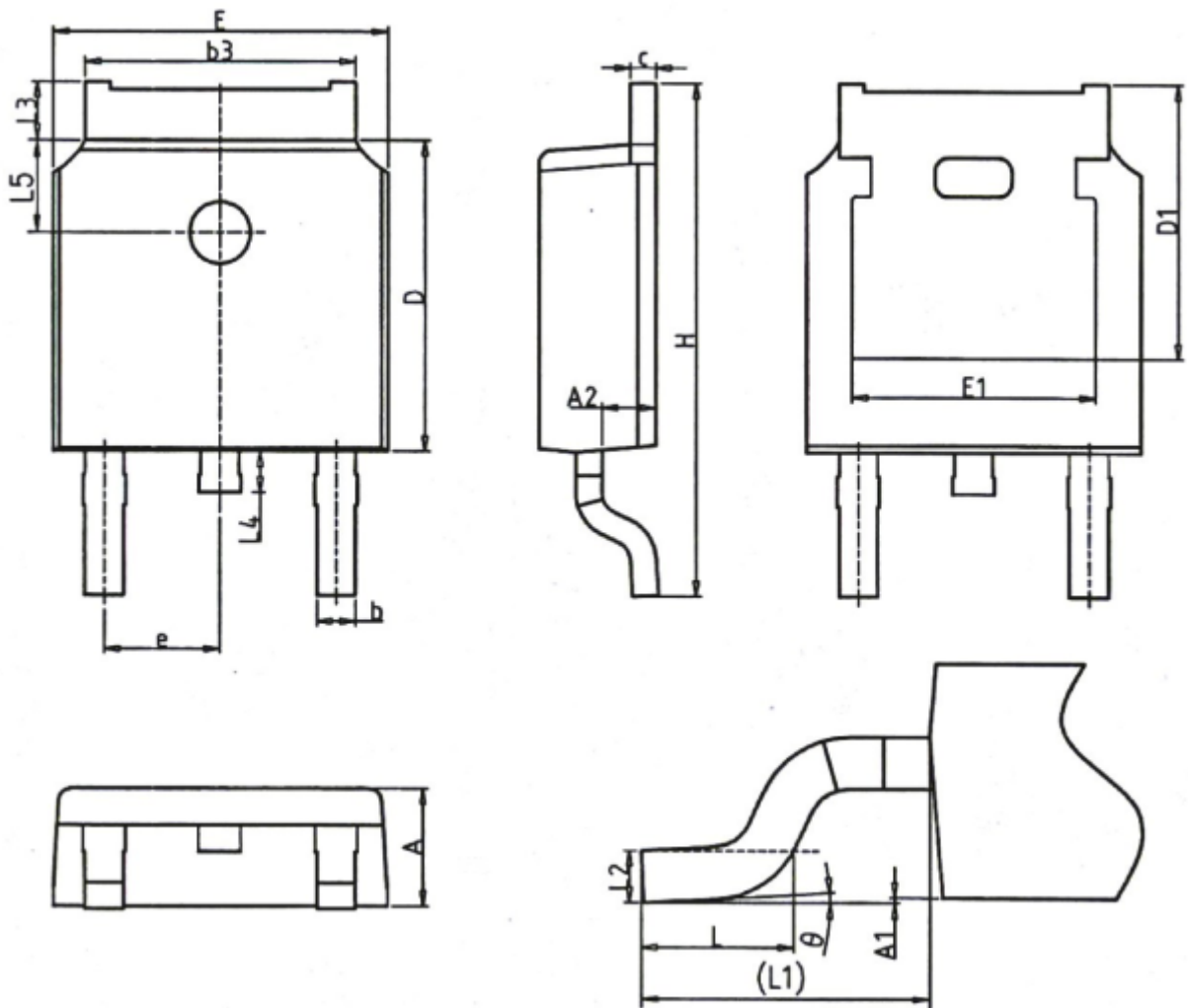


Figure C: Unclamped Inductive Switching Test Circuit and Waveform





### TO-252



Unit:mm			
Symbol	Min.	Nom	Max.
A	2.20	2.30	2.40
A1	0.00	-	0.20
A2	0.97	1.07	1.17
b	0.68	0.78	0.90
b3	5.20	5.33	5.50
c	0.43	0.53	0.63
D	5.98	6.10	6.22
D1	5.30 REF		
E	6.40	6.60	6.80
E1	4.63	-	-

Unit:mm			
Symbol	Min.	Nom	Max.
e	2.286 BSC		
H	9.40	10.10	10.50
L	1.38	1.50	1.75
L1	2.90 REF		
L2	0.51 BSC		
L3	0.88	-	1.28
L4	-	-	1.00
L5	1.65	1.80	1.95
θ	0°	-	8°



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